## Notice of References Cited Application/Control No. 10/527,687 Examiner SATH V. PERUNGAVOOR Applicant(s)/Patent Under Reexamination OKUNO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0030690 A1	03-2002	Someya et al.	345/598
*	В	US-6,724,398 B2	04-2004	Someya et al.	345/690
*	С	US-2004/0135798 A1	07-2004	Someya et al.	345/690
*	D	US-2005/0156944 A1	07-2005	Someya et al.	345/611
*	Е	US-2005/0244077 A1	11-2005	Kitamura et al.	382/261
*	F	US-2005/0243350 A1	11-2005	Aoyama, Tatsuya	358/001.9
*	G	US-2006/0045375 A1	03-2006	Okuno et al.	382/266
*	Ι	US-2008/0043145 A1	02-2008	Someya et al.	348/538
*	-	US-2008/0050032 A1	02-2008	Okuno et al.	382/266
*	J	US-7,330,199 B2	02-2008	Someya et al.	345/698
*	K	US-7,429,994 B2	09-2008	Someya et al.	345/698
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.